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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/602,724	. 06/25/2003	Yoshinao Harada	60188-555	1545
7590 08/19/2004			EXAMINER .	
McDermott, Will & Emery 600 13th Street, N.W. Washington, DC 20005-3096			ERDEM, FAZLI	
			ART UNIT	PAPER NUMBER
admington, 20 2000 to, 0			2826	-
			DATE MAILED: 08/19/2004	

Please find below and/or attached an Office communication concerning this application or proceeding.

		Application No.	Applicant(s)			
Office Action Summary		10/602,724	HARADA, YOSHINAO			
		Examiner	Art Unit			
		Fazli Erdem	2826			
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply						
A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.  - Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.  - If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.  - If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.  - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).						
Status						
1)🛛	1)⊠ Responsive to communication(s) filed on 25 June 2003.					
2a) <u></u> ☐	This action is <b>FINAL</b> . 2b)⊠ Thi	s action is non-final.				
3)□	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is					
	closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.					
Disposition of Claims						
4)🖂	4) Claim(s) 1-31 is/are pending in the application.					
	4a) Of the above claim(s) is/are withdrawn from consideration.					
· —	5) Claim(s) is/are allowed.					
· <u> </u>	☐ Claim(s) 1 and 6-31 is/are rejected.					
· —	<ul><li>✓ Claim(s) <u>2-5</u> is/are objected to.</li><li>☐ Claim(s) are subject to restriction and/or election requirement.</li></ul>					
0)[	are subject to restriction and	or election requirement.				
Applicati	on Papers					
•	The specification is objected to by the Examin					
10)	The drawing(s) filed on is/are: a) $\square$ acc					
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).						
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).						
11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.						
Priority under 35 U.S.C. § 119						
<ul> <li>12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).</li> <li>a) All b) Some * c) None of:</li> <li>1. Certified copies of the priority documents have been received.</li> <li>2. Certified copies of the priority documents have been received in Application No</li> <li>3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).</li> </ul>						
* See the attached detailed Office action for a list of the certified copies not received.						
Attachment(s)						
1) Notice of References Cited (PTO-892)  4) Interview Summary (PTO-413)						
3) 🔯 Inforn	e of Draftsperson's Patent Drawing Review (PTO-948) nation Disclosure Statement(s) (PTO-1449 or PTO/SB/08) r No(s)/Mail Date <u>06/25/2003</u> .	Paper No(s)/Mail Da  5) Notice of Informal Page  6) Other:	atent Application (PTO-152)			

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### **DETAILED ACTION**

## Allowable Subject Matter

1. Claims 2-5 objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

# Claim Rejections - 35 USC § 103

- 2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 3. Claims 1 and 6 rejected under 35 U.S.C. 103(a) as being unpatentable over Matsuo et al. (6,7373,716) in view of Park (2002/0001906).

Regarding Claims 1 and 6, Matsuo et al. disclose a semiconductor device and method of manufacturing the same with formation of multilayer gate insulating film containing metal where in Fig. 9, layer 92 is a TiSiON layer. Matsuo et al. fail to disclose the required high dielectric constant layer on top of this metal/silicon/oxygen/nitrogen insulating film. However, Park discloses a method of manufacturing a gate in a semiconductor device where in 1B, layer 13 is specified as HFSiO4, i.e. metal, oxygen, silicon.

It would have been obvious to one of having ordinary skill in the art at the time the invention was made to include the required high dielectric film in Matsuo et al. as taught by Park in order to have a gate insulating layer of higher reliability.

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## **Double Patenting**

4. The nonstatutory double patenting rejection is based on a judicially created doctrine grounded in public policy (a policy reflected in the statute) so as to prevent the unjustified or improper timewise extension of the "right to exclude" granted by a patent and to prevent possible harassment by multiple assignees. See *In re Goodman*, 11 F.3d 1046, 29 USPQ2d 2010 (Fed. Cir. 1993); *In re Longi*, 759 F.2d 887, 225 USPQ 645 (Fed. Cir. 1985); *In re Van Ornum*, 686 F.2d 937, 214 USPQ 761 (CCPA 1982); *In re Vogel*, 422 F.2d 438, 164 USPQ 619 (CCPA 1970); and, *In re Thorington*, 418 F.2d 528, 163 USPQ 644 (CCPA 1969).

A timely filed terminal disclaimer in compliance with 37 CFR 1.321(c) may be used to overcome an actual or provisional rejection based on a nonstatutory double patenting ground provided the conflicting application or patent is shown to be commonly owned with this application. See 37 CFR 1.130(b).

Effective January 1, 1994, a registered attorney or agent of record may sign a terminal disclaimer. A terminal disclaimer signed by the assignee must fully comply with 37 CFR 3.73(b).

Claims 7-31 rejected under the judicially created doctrine of obviousness-type double patenting as being unpatentable over claims 1- of U.S. Patent No. 6,642,131.

Although the conflicting claims are not identical, they are not patentably distinct from each other because in Claims 7-19, they both claim a method for producing a semiconductor device which comprises the steps of forming a high dielectric constant film containing a metal, oxygen and a predetermined substance on a substrate, performing a heat treatment with respect to the high dielectric constant film to diffuse silicon from the side of the substrate into the high dielectric constant film to form siliconcontaining high dielectric constant film and forming a conductive film for serving as a gate electrode on the silicon-containing high dielectric constant film. Regarding Claims 20-31, they both claim a method for producing a semiconductor device comprising the steps of forming a high dielectric constant film containing a metal, oxygen and hydrogen

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on a substrate, performing a heat treatment with respect to the high dielectric constant film to diffuse silicon from the side of the substrate into the high dielectric constant film in order to form a silicon-containing dielectric constant film and forming a conductive film for serving as a gate electrode on the silicon-containing high dielectric constant film.

#### Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Fazli Erdem whose telephone number is (571) 272-1914. The examiner can normally be reached on M - F 8:00 - 5:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nathan Flynn can be reached on (571) 272-1915. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

FΕ

August 9, 2004

NATHAN J. FLYNN

SUPERVISORY PATENT EXAMINED
TECHNOLOGY CENTER 2800